

Notice of References Cited	Application/Control No. 10/563,660		Applicant(s)/Patent Under Reexamination OKUBO, MIWA	
	Examiner John P. Zimmermann		Art Unit 2861	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Institute of Electrical and Electronics Engineers (IEEE): Dictionary.com, "Room Temperature," in The American Heritage® Dictionary of the English Language, Fourth Edition. Source location: Houghton Mifflin Company, 2004. http://dictionary.reference.com/browse/Room Temperature . Available: http://dictionary.reference.com . Accessed: April 22, 2010.
	V	American Society for Testing and Materials (ASTM): "Room temperature shall be considered to be 50 °F to 100 °F [10 to 38 °C] unless otherwise specified." Accessed: April 22, 2010.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.